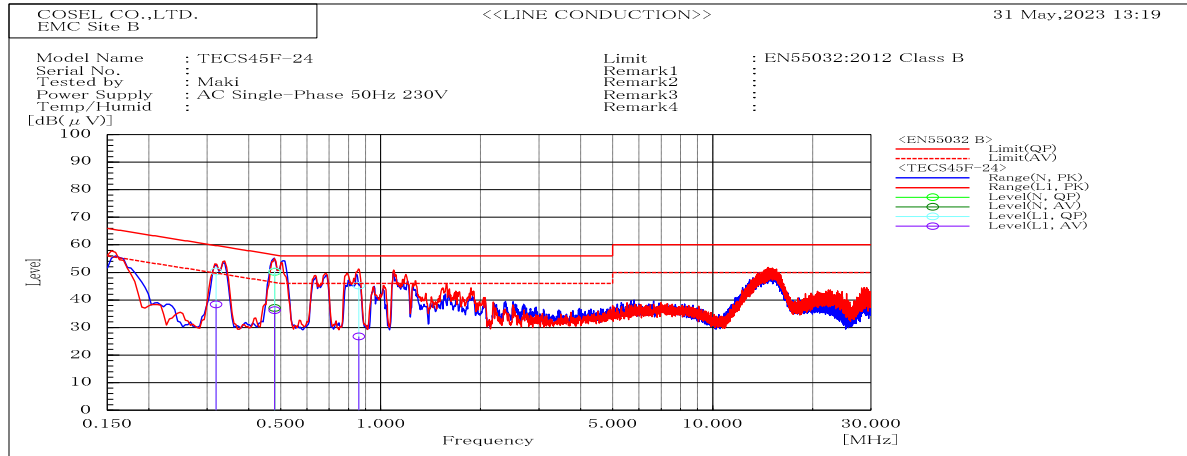
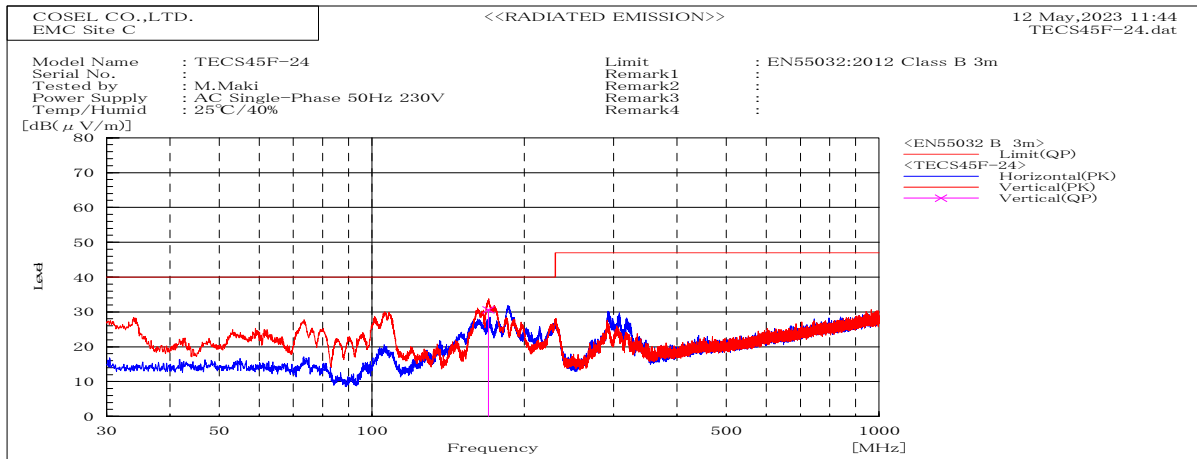


DATA SHEET		Date	12-Oct-23
Model	TECS45F-24	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Maki



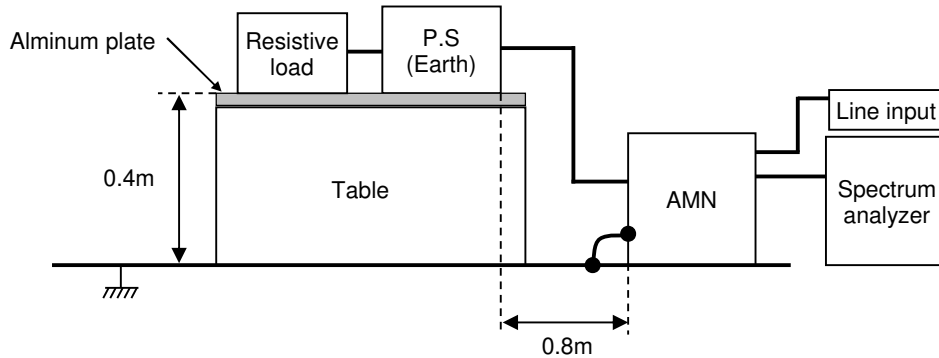
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.319	L1	50.4	38.4	59.7	49.7	9.3	11.3	Pass	
0.479	L1	50.4	36.3	56.4	46.4	6	10.1	Pass	
0.479	N	50.2	37.1	56.4	46.4	6.2	9.3	Pass	
0.859	L1	45.2	26.8	56	46	10.8	19.2	Pass	



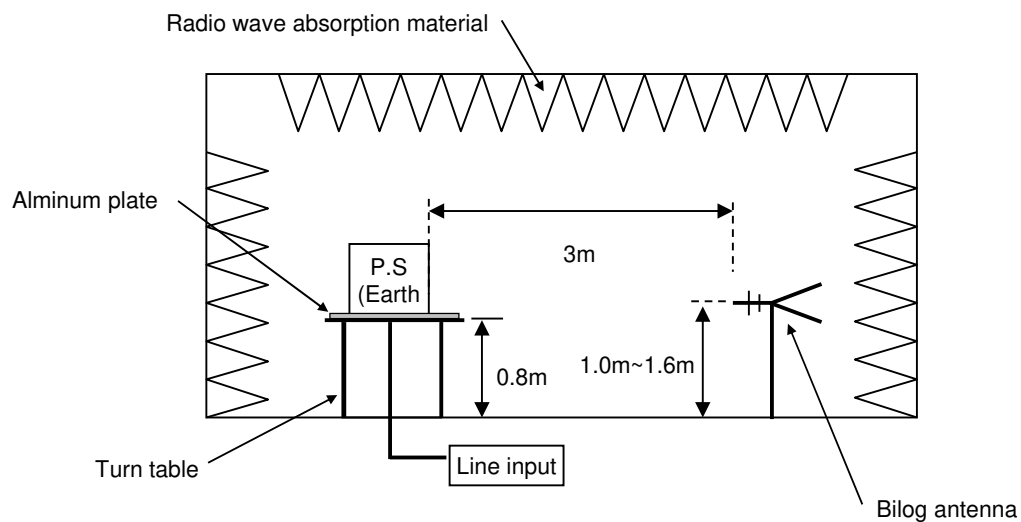
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
169.859	V	Stable	30.6	40	9.4	Pass	100.2	28.4	

DATA SHEET		Date	12-Oct-23
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Maki

1. Line conduction



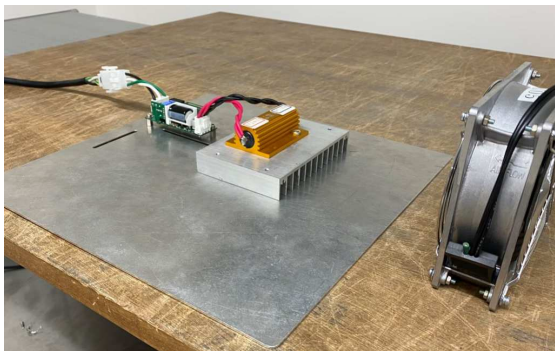
2. Radiated emission



Conditions

Test : EMI
Model Nam: TECS45F-24

1.LINE CONDUCTION



2.RADIATED EMISSION

